



Business Environment Council Limited – IAQ Solutions Centre

商界環保協會有限公司 – 室內空氣技術服務中心

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TYPE OF INSPECTION BODY : A : Provides 'third party' inspection service to the public 向公
檢驗機構類別 眾提供「第三方」檢驗服務

ACCREDITED INSPECTION : Indoor Air Quality Inspection 室內空氣質素檢驗
FIELD
認可檢驗領域

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Indoor Air Quality Inspection 室內空氣質素檢驗		
ITEM INSPECTED 檢驗項目	SPECIFIC PROPERTY OR CHARACTERISTIC INSPECTED 特定檢驗特性或特徵	SPECIFIC INSPECTION METHOD OR STANDARD 特定檢驗方法或標準
Indoor Air Quality	On-site measurement of : - Temperature - Relative Humidity - Air Movement - Carbon Dioxide - Carbon Monoxide - Respirable Suspended Particulate - Total Volatile Organic Compound - Radon - Ozone On-site sampling of : - Airborne Bacteria - Formaldehyde - Nitrogen Dioxide Walkthrough Inspection IAQ Compliance Assessment	A Guide on Indoor Air Quality Certification Scheme for Offices and Public Places, The Government of the HKSAR, Indoor Air Quality Management Group, September 2003 Annex 3 (a), as documented in CIB-WI-01 (Thermistor) Annex 3 (a), as documented in CIB-WI-02 (Thin-film capacitive) Annex 3 (a), as documented in CIB-WI-03 (Hot wire velocity probe) Annex 3 (b), as documented in CIB-WI-04 (Non-dispersive infrared NDIR) Annex 3 (b), as documented in CIB-WI-05 (Electrochemical sensor) Annex 3 (g), as documented in CIB-WI-06 (Light scattering laser diode) Annex 3 (h), as documented in CIB-WI-07 (Photo-ionization sensor) Annex 3 (c), as documented in CIB-WI-08 (Diffused junction photodiode) Annex 3 (f), as documented in CIB-WI-09 (Heated metal oxide semiconductor) Annex 3 (i), as documented in CIB-WI-10 (Centrifugal sampler) Annex 3 (d), as documented in CIB-WI-11 (Passive sampler) Annex 3 (e), as documented in CIB-WI-12 (Passive sampler) Clause 11 Clause 13 to Clause 28